

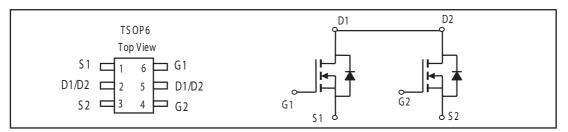
Jun,08 2005 ver 1.4

Dual N-Channel Enhancement Mode Field Effect Transistor

PRODUCT SUMMARY					
VDSS	ID	RDS(ON) (m Ω) Max			
20V	4A	30 @ VGS = 4.0V 46 @ VGS = 2.5V			

FEATURES

- Super high dense cell design for low R DS(ON).
- Rugged and reliable.
- Surface Mount Package.



ABSOLUTE MAXIMUM RATINGS (TA=25 °C unless otherwise noted)

Parameter	S ymbol	Limit	Unit
Drain-S ource Voltage	VDS	20	V
Gate-Source Voltage	VGS	±10	V
Drain Current-Continuous @ T = 25°C	ID	4	A
-Pulsed ^b	IDM	25	А
Drain-Source Diode Forward Current ^a	Is	2	А
Maximum Power Dissipation ^a	PD	1.25	W
Operating Junction and Storage Temperature Range	TJ, TSTG	-55 to 150	°C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient ^a	R ∂JA	100	°C/W

ELECTRICAL CHARACTERISTICS (TA = 25 °C unless otherwise noted)

Parameter	S ymbol	Condition	Min	Тур	Max	Unit		
OFF CHARACTERISTICS								
Drain-Source Breakdown Voltage	BVDSS	Vgs =0V, ID =250uA	20			V		
Zero Gate Voltage Drain Current	loss	VDS =16V, VGS = 0V			1	uA		
Gate-Body Leakage	lgss	$VGS = \pm 10V, VDS = 0V$			±100	nA		
ON CHARACTERISTICS ^b								
Gate Threshold Voltage	VGS(th)	$V_{DS} = V_{GS}$, $I_D = 250uA$	0.5	0.8	1.5	V		
Drain-Source On-State Resistance	R ds (on)	$V_{GS} = 4.0V, I_{D} = 4A$		27	30	m ohm		
		VGS =2.5V, ID = 3A		35	46	m ohm		
Forward Transconductance	g _{FS}	VDS = 5V, ID =4A		13		S		
DYNAMIC CHARACTERISTICS C	DYNAMIC CHARACTERISTICS ^c							
Input Capacitance	CISS			800		PF		
Output Capacitance	Coss	V DS = 8V, V GS = 0V f = 1.0MHz		155		рF		
Reverse Transfer Capacitance	CRSS			125		ΡF		
SWITCHING CHARACTERISTICS	SWITCHING CHARACTERISTICS C							
Turn-On Delay Time	tD(ON)	VDD = 10V,		18.3		ns		
R ise Time	tr	ID = 1A, Vgen = 4.0V,		4.8		ns		
Turn-Off Delay Time	tD(OFF)	RL = 10 ohm		43.5		ns		
Fall Time	tf	RGEN = 10 ohm		20		ns		
Total Gate Charge	Qg			11		nC		
Gate-Source Charge	Qgs	VDS =10V, ID = 4A, VGS =4.0V		2.2		nC		
Gate-Drain Charge	Qgd			2.5		nC		

ELECTRICAL CHARACTERISTICS (T_A=25 °C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit	
DRAIN-SOURCE DIODE CHARACTERISTICS b							
Diode Forward Voltage	VsD	VGS = 0V, $IS = 2A$		0.8	1.2	V	

Notes

a.S urface Mounted on FR4 Board, t≤10sec.

b.Pulse Test:Pulse Width \leq 300us, Duty Cycle \leq 2%.

c.Guaranteed by design, not subject to production testing.

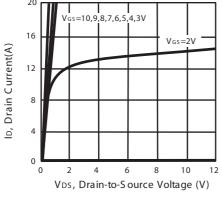


Figure 1. Output Characteristics

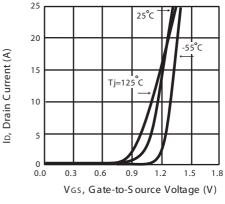


Figure 2. Transfer Characteristics

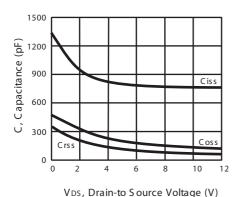


Figure 3. Capacitance

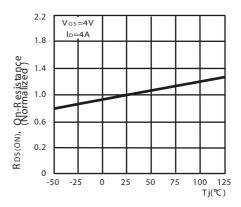
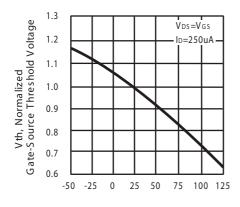
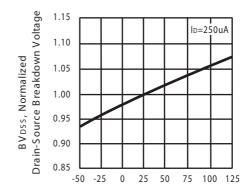


Figure 4. On-Resistance Variation with Temperature



Tj, Junction Temperature (°C)



Tj, Junction Temperature (°C)

with Temperature

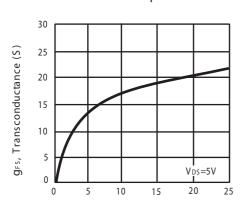
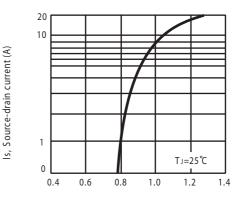


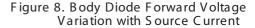
Figure 6. Breakdown Voltage Variation with Temperature



IDS, Drain-Source Current (A)

Figure 7. Transconductance Variation with Drain Current

Vsp, Body Diode Forward Voltage (V)



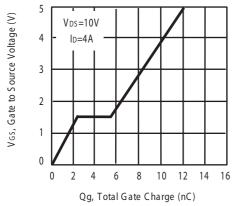
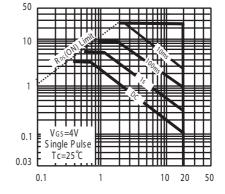


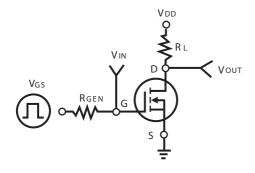
Figure 9. Gate Charge



VDS, Drain-Source Voltage (V)

Figure 10. Maximum Safe Operating Area

lb, Drain Current (A)



td(on) tr td(off) tf 90%

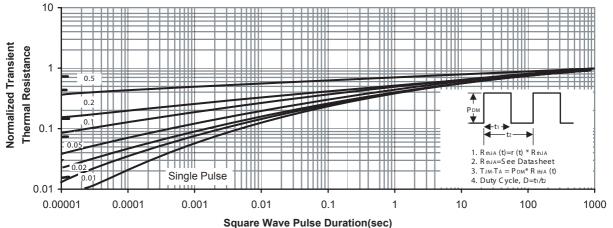
VOUT 10% INVERTED 10%

VIN 10%

PULSE WIDTH

Figure 11. S witching Test Circuit

Figure 12. Switching Waveforms



Normalized Thermal Transient Impedance Curve

PACKAGE OUTLINE DIMENSIONS

